



47 CFR PART 15B

TEST REPORT

of

CDMA Phone

Model Name: CT800P
Brand Name: CANTV
Report No.: SZ08120019E01
FCC ID: WVB-CT800P

prepared for

Brightstar Corporation.

9725 NW 117th Ave#300 Miami-FL 33178-USA

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1. Test Result Certification

Equipment under Test: CDMA Phone

Brand Name: CANTV

Model Name: CT800P

FCC ID: WVB-CT800P

Applicant: Brightstar Corporation.

9725 NW 117th Ave#300 Miami-FL 33178-USA

Manufacturer: LINKTOP TECHNOLOGY CO., LTD..

Guangye Building, Torch Hi-Tech Industrial Development Zone, Xiamen, China

Emission Designator: 1M25F9W

Test Standards: 47 CFR Part 2

47 CFR Part 15 Subpart B

Test date: December 1, 2008 –December 14, 2008

Test Result: PASS

* We Hereby Certify That:

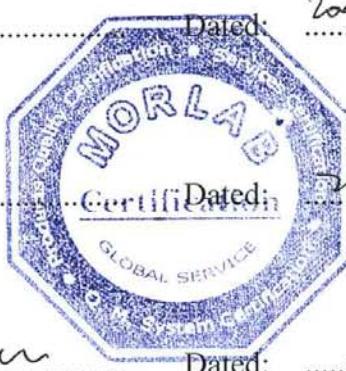
The equipment under test was tested by Shenzhen Morlab Communications Technology Co., Ltd. The test data, data evaluation, test procedures and equipment configurations shown in this report were made in accordance with the requirement of related FCC rules.

The test results of this report only apply for the tested sample equipment identified above. The test report shall be invalid without all the signatures of the test engineer, the reviewer and the approver.

Tested by: Li Yi; Dated: 2008.12.18
Li Yi

Reviewed by: Wei Yanquan; Dated: 2008.12.18
Wei Yanquan

Approved by: Shu Luan; Dated: 2008.12.18
Shu Luan



2. General Information

2.1 Equipment under Test (EUT) Description

Description CDMA Phone
Model Name CT800P
Brand Name CANTV
Serial No. CT800PHBUSK
MEID (n.a)
Hardware Version CT800P-DATA-V1.3
Software Version HT618-VENV1.00-081112.bin
Modulation CDMA 1X
Frequency Tx: 825.25-847.75MHz; Rx: 870.25-892.75MHz
Power Supply: Battery
Brand name: BOFUNENG/SHIDE
Model Name: LT50AA 1200H (PN: 11W0012)
Capacitance: 1200mAh
Rated voltage: 3.6V
Charge limited: 4.3V
Manufacturer: Jiangsu Cell Battery Co., Ltd.
No.47, Jianshe Road, Licheng Town, Jinhua,
Huai'an, Jiangsu, China
Accessory Equipment: AC Adapter (Charger for Battery)
Brand Name: Chi Yuan
Model Name: CHG50100-3A
Rated Input: ~ 100V-240V, 0.2A, 50/60Hz
Rated Output: = 5V, 1A
Manufacturer: Shenzhen Chi Yuan Industrial Co Ltd.
City Plaza, B1 Bldg, 13th Fl, Room C, Chang An
Town, Dongguan, Guangdong 523850 Cn
Wire Length: 145cm

NOTE:

1. The EUT is a model of CDMA 1X mobile station operating in Cellular band.
2. The normal configuration for the EUT is the CDMA Phone (MS) associated with ancillary equipments e.g. the Battery and/or the AC Adapter (Charger).
3. For detailed features about the EUT, please see user manual supplied by the applicant.

2.2 Test Standards and Results

The objective of the report is to perform tests according to 47 CFR Part 2, Part 15 Part 22 for FCC ID Certification:

No.	Identity	Document Title
1	47 CFR Part 2 (10-1-05 Edition)	Frequency Allocations and Radio Treaty Matters; General Rules and Regulations
2	47 CFR Part 15 (10-1-05 Edition)	Radio Frequency Devices

Test detailed items and the results are as below:

No.	Rules	Test Type	Result	Date of Test
FCC Part 15 Requirement				
1	§15.107	Conducted Emissions	PASS	2008-12-13
2	§15.109	Radiated Emissions	PASS	2008-12-13

NOTE:

The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.

2.3 Facilities and Accreditations

2.3.1 Facilities

Shenzhen Electronic Product Quality Testing Center Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is CNAS L1659.

All measurement facilities used to collect the measurement data are located at Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, P. R. China. The site was constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22, the FCC registration number is 741109.

2.3.2 Test Equipments

No.	Description	Specification		
1	System Simulator	Manufacturer:	Rohde&Schwarz	
		Model No.:	CMU200	
		Serial No.:	100448	
2	System Simulator	Manufacturer:	Agilent	
		Model No.:	E5515C	
		Serial No.:	GB43130131	
3	Spectrum Analyzer	Manufacturer:	Agilent	
		Model No.:	E7405A	
		Serial No.:	US44210471	
4	Telecommunication Antenna	Manufacturer:	European Antennas	
		Model No.:	PSA-45010R/356	
		Serial No.:	403688-001	
5	Trilogy Antenna	Manufacturer:	Schwarzbeck	
		Model No.:	VULB 9163	
		Serial No.:	9163-274	
6	Horn Antenna	Manufacturer:	Schwarzbeck	
		Model No.:	BBHA 9120C	
		Serial No.:	9120C-384	
7	Power Splitter	Manufacturer:	WEINSCHEL	
		Model No.:	1506A	
		Serial No.:	NW521	
8	Anechoic Chamber	Manufacturer:	Albatross Projects GmbH	
9	DC Power Supply	Manufacturer:	Good Will Instrument Co., Ltd.	
10	Temperature Chamber	Manufacturer:	Chongqing YinHe Experimental Equip. Co., Ltd.	

NOTE:

1. Equipments listed above have been calibrated and are in the period of validation.

2.3.3 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature:	20 - 25°C
Relative Humidity:	40 - 60%
Atmospheric Pressure:	86-106kPa

3. 47 CFR Part 15B Requirements

3.1 General Information

3.1.1 Test Mode

The test modes of the EUT are showed as below:

(1) Call Mode:

The EUT configuration of the emission tests was MS + Battery + Charger +Headset.

Before the measurement, the lithium battery was completely discharge.

During the measurement, the lithium battery was installed into the MS, and the charger was connected to the MS. A communication link was established between the MS and a System Simulator (SS).

(2) USB Test Mode

The EUT configuration of the emission tests is EUT + Battery + PC.

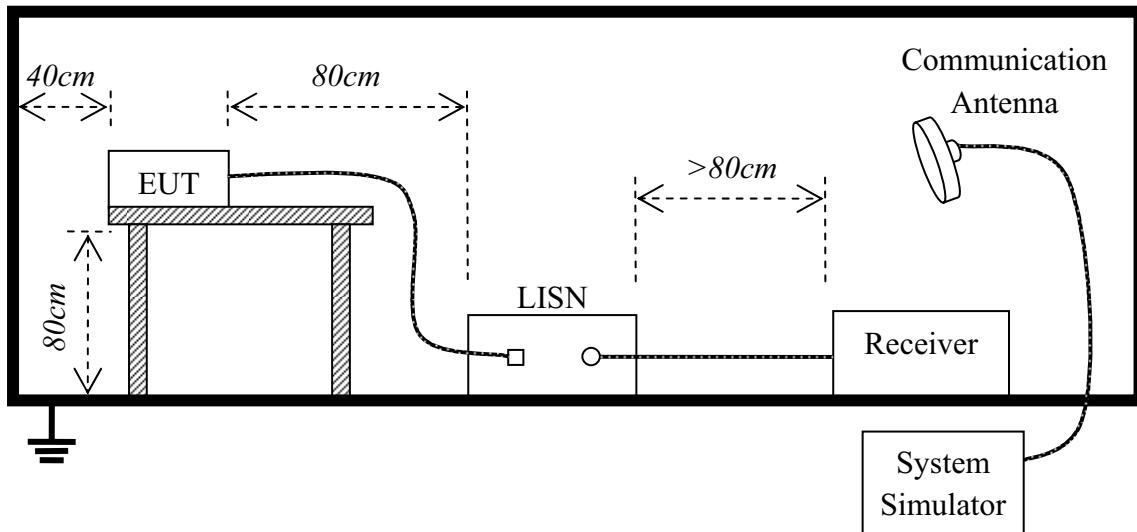
In this test mode, the EUT is connected with a PC via a special USB cable supplied by applicant.

NOTE:

1. All test modes are performed, only the worst cases are recorded in this report.

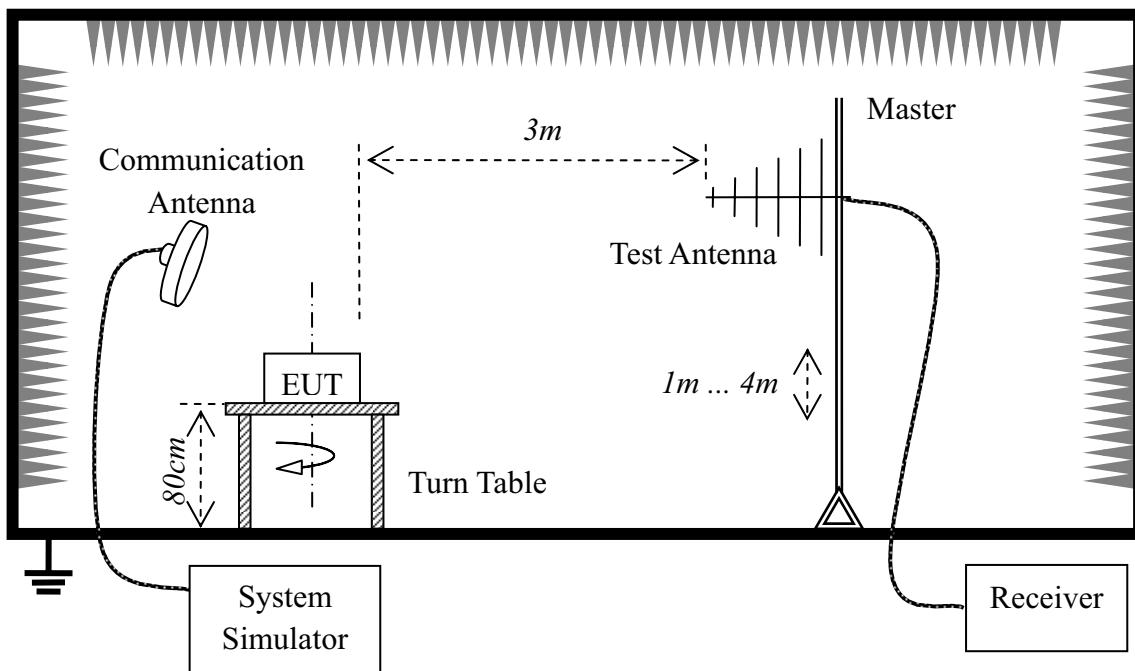
3.1.2 Test Setup

3.1.2.1 Conducted Emission Test



1. The test is performed in a Shield Room; the factors of the test system are calibrated to correct the reading.
2. The EUT is placed on a 0.8 meters high insulating table and keeps 0.4 meters away from the conducting wall of the Shield Room.
3. The EUT is connected to the power mains through a Line Impedance Stabilization Network (LISN). The LISN provides $50\Omega/50\mu\text{H}$ of coupling impedance for the measuring instrument.

3.1.2.2 Radiated Emission Test



1. The test is performed in a Semi-anechoic Chamber; the factors of the test system are calibrated to correct the reading.
2. The EUT is placed on a 0.8 meters high insulating table and keeps 3 meters away from the trilogy Test Antenna, which is mounted on the top of a variable-height antenna Master tower.

NOTE:

1. The test method is the substitution method according to TIA-603-C.

3.2 Conducted Emission

3.2.1 Requirement

According to FCC §15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

1. The limit subjects to the Class B digital device.
2. The lower limit shall apply at the band edges.
3. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

3.2.2 Test Procedure

1. Perform test setup as described in section 3.1.2.1.
2. Each test mode in section 3.1.1 should be applied. At each test mode, the frequency range from 150 kHz to 30MHz is searched using the CISPR Quasi-Peak and/or the Average detector of the Receiver. If the emission levels measured with Quasi-Peak detector are lower than the Average Limit, it's not necessary to measure with Average detector.
3. The emission levels at both L phase and N phase should be tested.
4. Record the test result plot and distinct points.
5. In the test report show the worst test data.

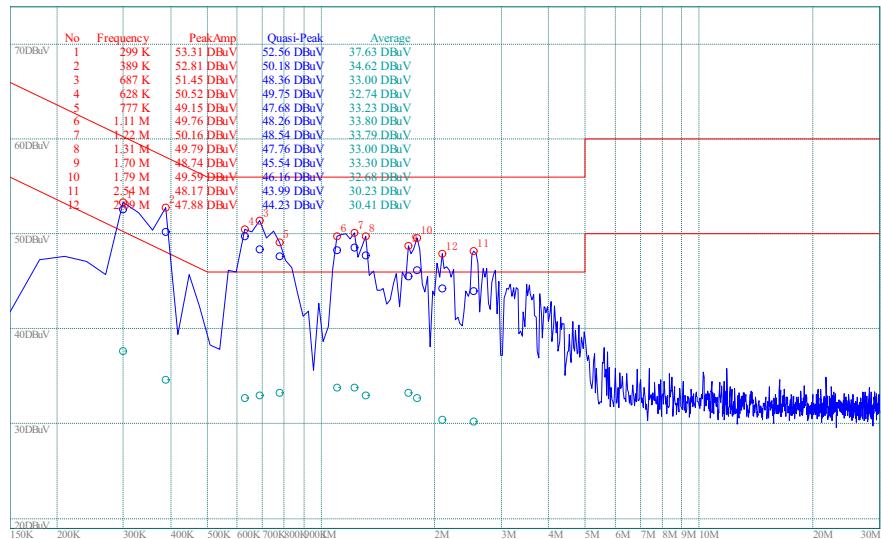
3.2.3 Test Result

(1) Call Mode

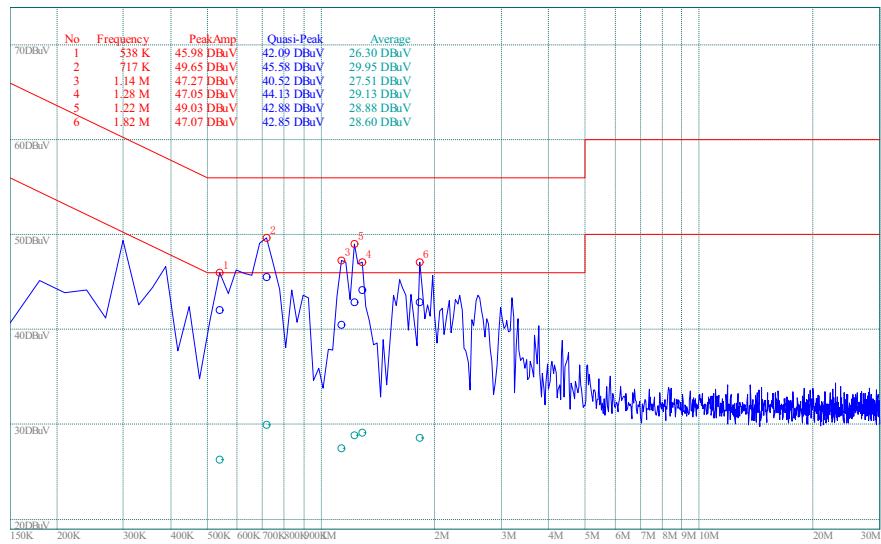
A. Test Verdict Recorded for Suspicious Points:

No.	@Frequency (MHz)	Measured Emission Level (dB μ V)				Limit (dB μ V)		Verdict
		PK	QP	AV	Phase	QP	AV	
1	0.687	51.45	48.36	33.00	L	56.0	46.0	PASS
2	0.777	49.15	47.68	33.23	L	56.0	46.0	PASS
3	1.22	50.16	48.54	33.79	L	56.0	46.0	PASS
4	0.717	49.65	45.58	29.95	N	56.0	46.0	PASS
5	1.22	49.03	42.88	28.88	N	56.0	46.0	PASS
6	1.82	47.07	42.85	28.60	N	56.0	46.0	PASS

B. Test Plot



(Plot A: L Phase)



(Plot B: N Phase)

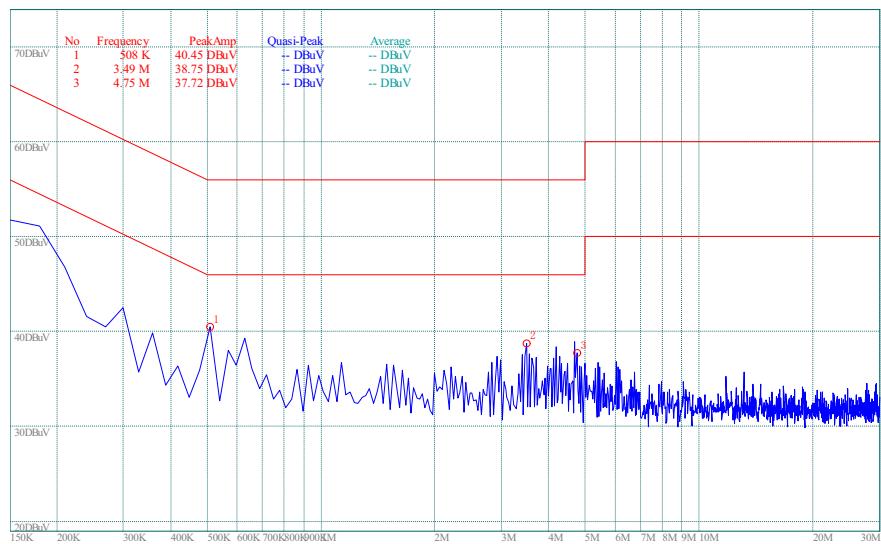
(2)USB Mode

A. Test Verdict Recorded for Suspicious Points:

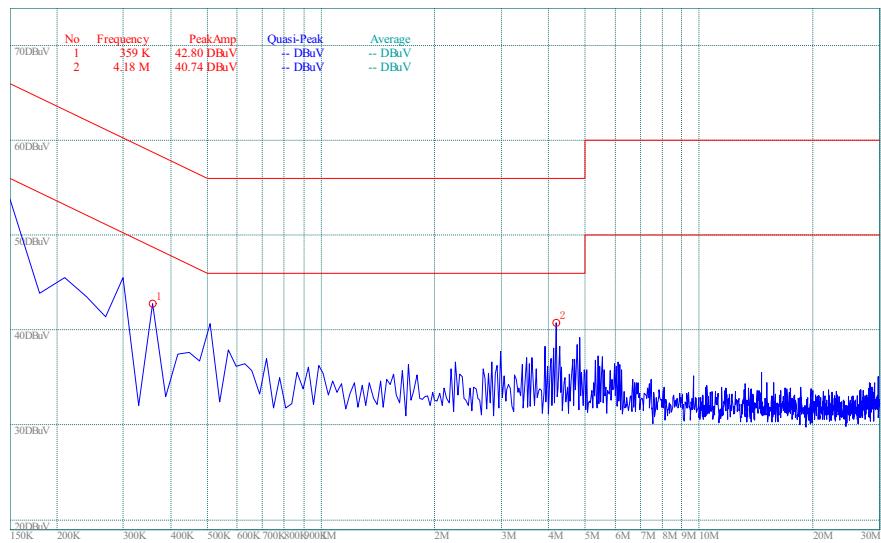
No.	@Frequency (MHz)	Measured Emission Level (dB μ V)				Limit (dB μ V)		Verdict
		PK	QP	AV	Phase	QP	AV	
1	0.508	40.45	--	--	L	56.0	46.0	PASS
2	3.49	38.75	--	--	L	56.0	46.0	PASS
3	4.75	37.72	--	--	L	56.0	46.0	PASS
4	4.18	40.74	--	--	N	56.0	46.0	PASS

Note: “--” in the table above means that the emissions are too small to be measured and are at least 10 dB below the limit.

B. Test Plot



(Plot A: L Phase)



(Plot A: N Phase)

3.3 Radiated Emission

3.3.1 Requirement

According to FCC §15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength	
	µV/m	dBµV/m
30 - 88	100	40
88 - 216	150	43.5
216 - 960	200	46
Above 960	500	54

NOTE:

1. Field Strength (dBµV/m) = $20 \cdot \log[\text{Field Strength } (\mu\text{V/m})]$.
2. In the emission tables above, the tighter limit applies at the band edges.

3.3.2 Test Procedure

1. Perform test setup as described in section 3.1.2.2.
2. Each test mode in section 3.1.1 should be applied. At each test mode, the Turn Table turns from 0 degrees to 360 degrees to find the maximum reading; for the suspected points, the Test Antenna varies from 1 meter to 4 meters to determine the maximum value of the field strength.
3. The Receiver is set to Peak Detector function and specified bandwidth with maximum hold mode. If the emission level of the EUT in peak mode is 6dB lower than the limit specified, then testing could be stopped and the peak values would be reported; otherwise the emission less than 6dB margins would be retested one by one using the quasi-peak method.
4. The emission levels at both horizontal and vertical polarizations should be tested.
5. Record the test result plot and distinct points.
6. In the test report show the worst test data.

3.3.3 Test Result

(1) Call Mode

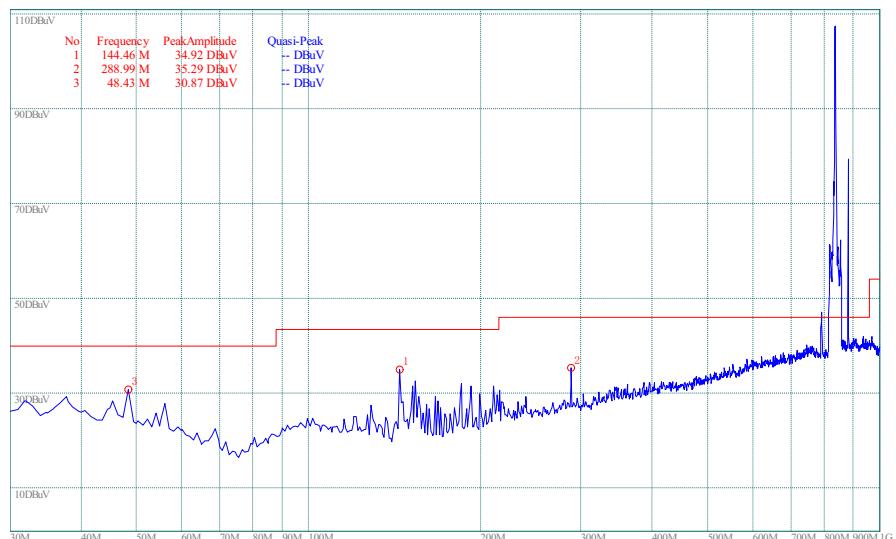
A. Test Verdict Recorded for Suspicious Points:

No.	Frequency (MHz)	Emission Level (dB μ V/m)			Quasi-Peak Limit (dB μ V/m)	Result
		Peak	Quasi-Peak	Antenna Polarization		
1	48.43	30.87	--	Vertical	40.0	PASS
2	144.46	34.92	--	Vertical	43.5	PASS
3	288.99	35.29	--	Vertical	46.0	PASS
4	48.43	34.47	--	Horizontal	40.0	PASS
5	268.62	39.98	--	Horizontal	46.0	PASS

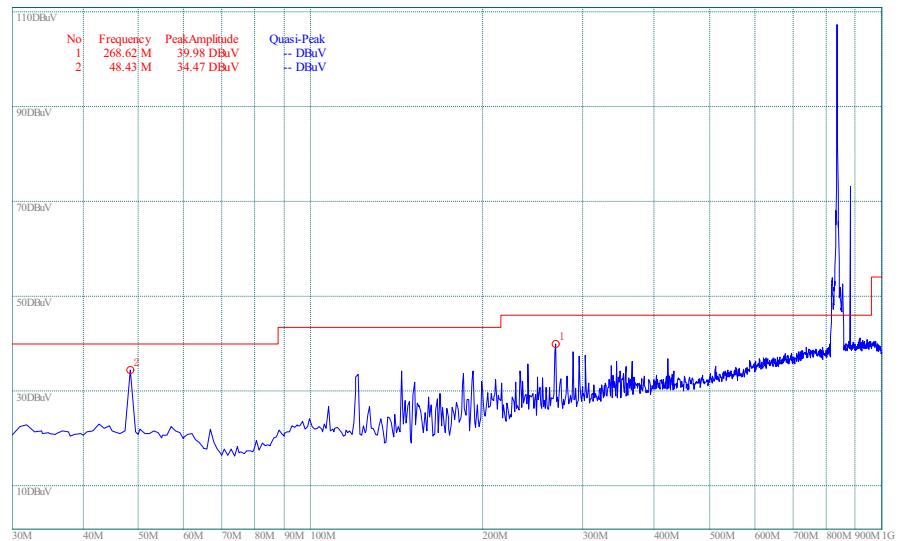
Note: "--" in the table above means that the emissions are too small to be measured and are at least 10 dB below the limit.

B. Test Plot

Following is the plots for emission measurement; please note that marked spikes with circle should be ignored because they are MS and SS carrier frequency.



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

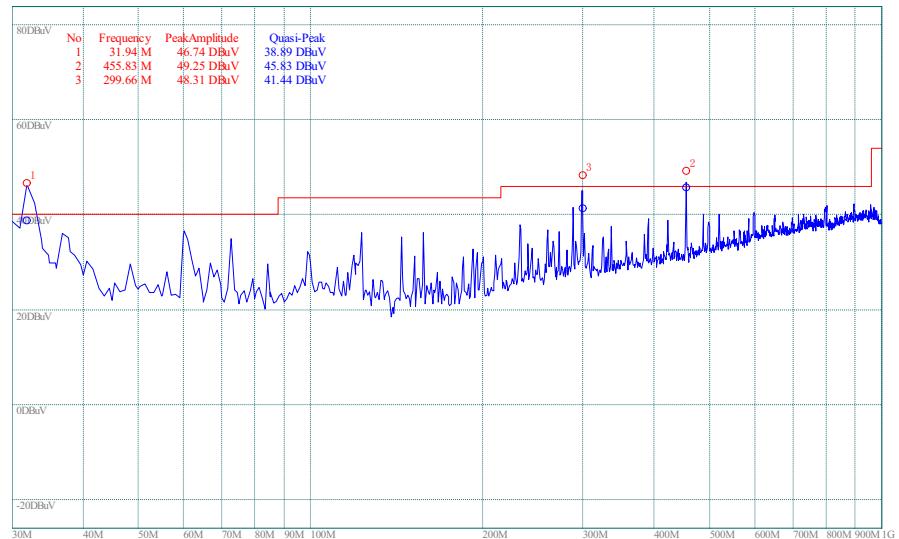
(2)USB Mode

A. Test Verdict Recorded for Suspicious Points:

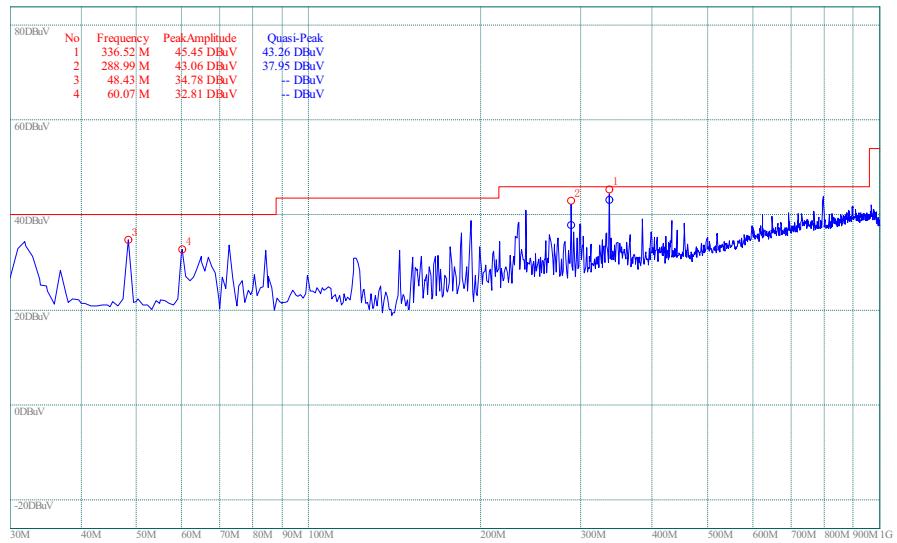
No.	Frequency (MHz)	Emission Level (dBµV/m)			Quasi-Peak Limit (dBµV/m)	Result
		Peak	Quasi-Peak	Antenna Polarization		
1	31.94	46.74	38.89	Vertical	40.0	PASS
2	299.66	48.31	41.44	Vertical	46.0	PASS
3	60.07	32.81	--	Horizontal	40.0	PASS
4	336.52	45.45	43.26	Horizontal	46.0	PASS

Note: "--" in the table above means that the emissions are too small to be measured and are at least 10 dB below the limit.

B. Test Plot



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

***** END OF REPORT*****